

SEMiX 302GB176HDs



SEMiX® 2s

Trench IGBT Modules

SEMiX 302GB176HDs

Preliminary Data

Features

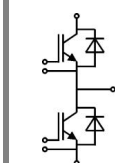
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability

Typical Applications

- AC inverter drives
- UPS
- Electronic welders

Remarks

- short circuit capability is tested @ $V_{CC}=1000V$ (all other static parameters are tested @ $V_{CC}=120$)



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Absolute Maximum Ratings		$T_{case} = 25^{\circ}C$, unless otherwise specified		
Symbol	Conditions	Values	Units	
IGBT				
V_{CES}	$T_j = 25^{\circ}C$	1700	V	
I_C	$T_j = 150^{\circ}C$	$T_c = 25^{\circ}C$	305	A
		$T_c = 80^{\circ}C$	220	A
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$	400	A	
V_{GES}		± 20	V	
t_{psc}	$V_{CC} = 1200V$; $V_{GE} \leq 20V$; $T_j = 125^{\circ}C$ $V_{CES} < 1700V$	10	μs	
Inverse Diode				
I_F	$T_j = 150^{\circ}C$	$T_c = 25^{\circ}C$	385	A
		$T_c = 80^{\circ}C$	260	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	400	A	
I_{FSM}	$t_p = 10ms$; sin.	$T_j = 25^{\circ}C$	2000	A
Module				
$I_{t(RMS)}$		600	A	
T_{vj}		- 40 ... + 150	$^{\circ}C$	
T_{stg}		- 40 ... + 125	$^{\circ}C$	
V_{isol}	AC, 1 min.	4000	V	

Characteristics		$T_{case} = 25^{\circ}C$, unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
IGBT					
$V_{GE(th)}$	$V_{GE} = V_{CE}$; $I_C = 8mA$	5,2	5,8	6,4	V
I_{CES}	$V_{GE} = 0V$; $V_{CE} = V_{CES}$	$T_j = 25^{\circ}C$		0,45	mA
		$T_j = 125^{\circ}C$			mA
V_{CE0}		$T_j = 25^{\circ}C$	1	1,2	V
		$T_j = 125^{\circ}C$	0,9	1,1	V
r_{CE}	$V_{GE} = 15V$	$T_j = 25^{\circ}C$	5	6,3	m Ω
		$T_j = 125^{\circ}C$	7,8	9	m Ω
$V_{CE(sat)}$	$I_{Cnom} = 200A$; $V_{GE} = 15V$	$T_j = 25^{\circ}C_{chiplev.}$	2	2,45	V
		$T_j = 125^{\circ}C_{chiplev.}$	2,45	2,9	V
C_{ies}	$V_{CE} = 25$; $V_{GE} = 0V$	$f = 1MHz$	17,6		nF
C_{oes}			0,73		nF
C_{res}			0,58		nF
Q_G	$V_{GE} = -8V \dots +15V$		1850		nC
$t_{d(on)}$	$R_{Gon} = 6,5\Omega$	$V_{CC} = 1200V$ $I_{Cnom} = 200A$ $T_j = 125^{\circ}C$	225		ns
t_r			45		ns
E_{on}			130		mJ
$t_{d(off)}$	$R_{Goff} = 6,5\Omega$	$T_j = 125^{\circ}C$	665		ns
t_f			105		ns
E_{off}			77		mJ
$R_{th(j-c)}$	per IGBT		0,1		K/W

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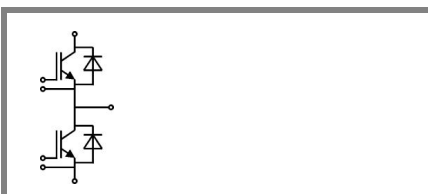
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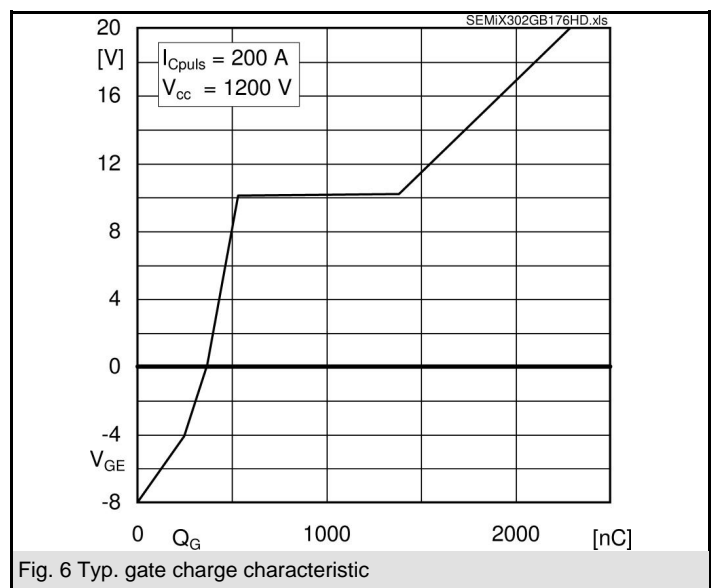
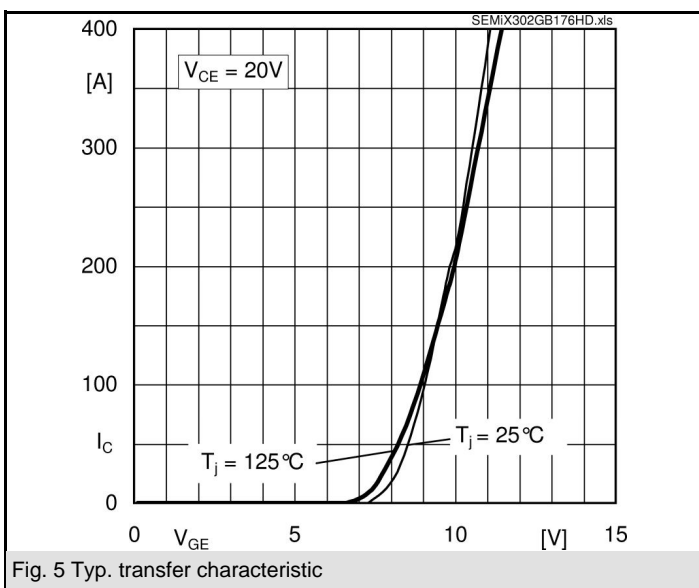
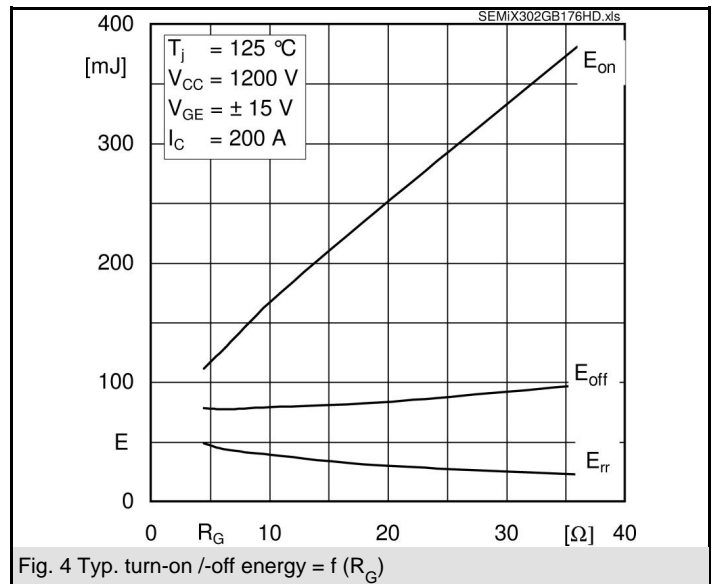
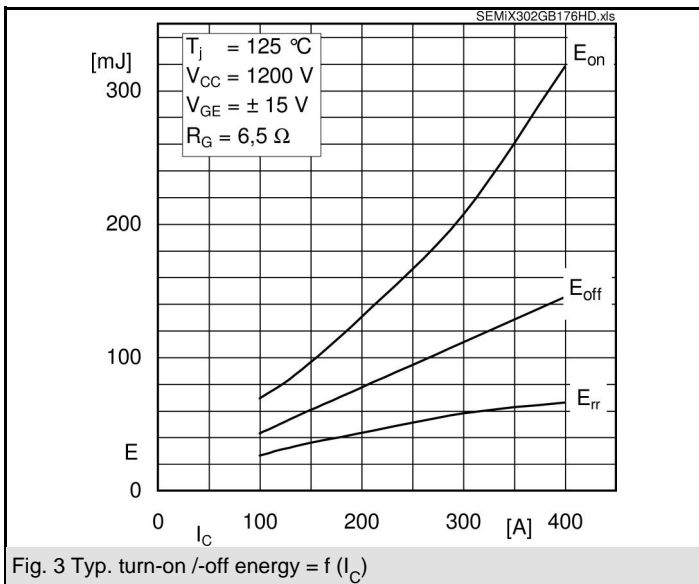
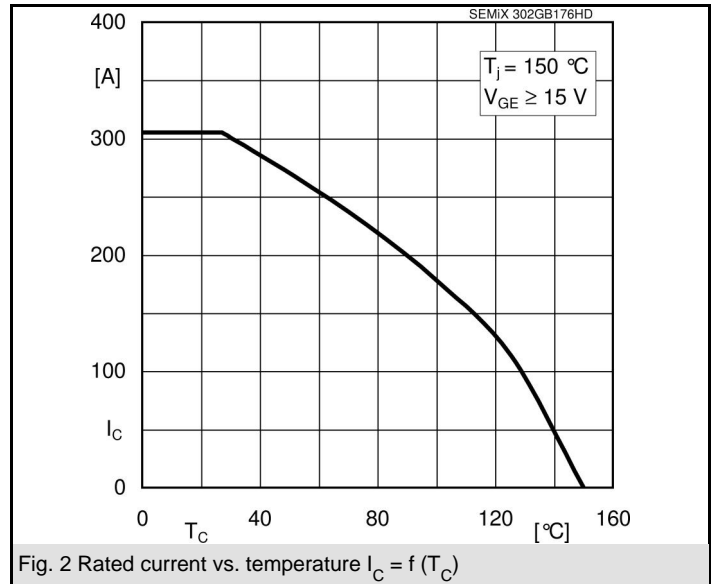
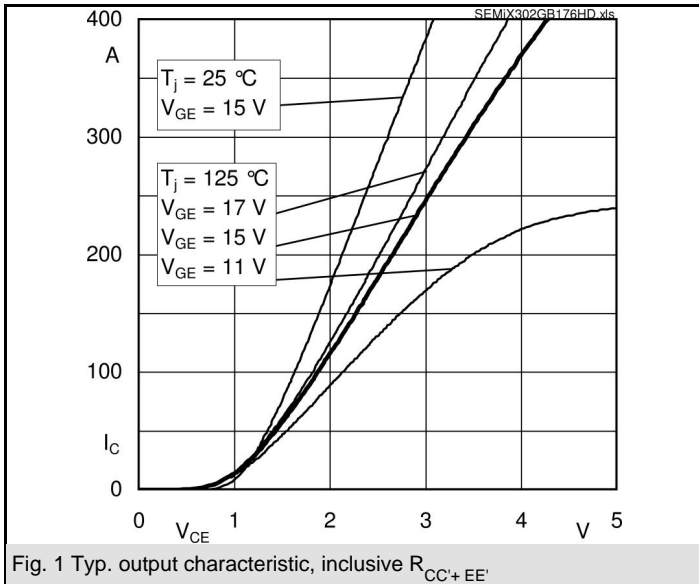


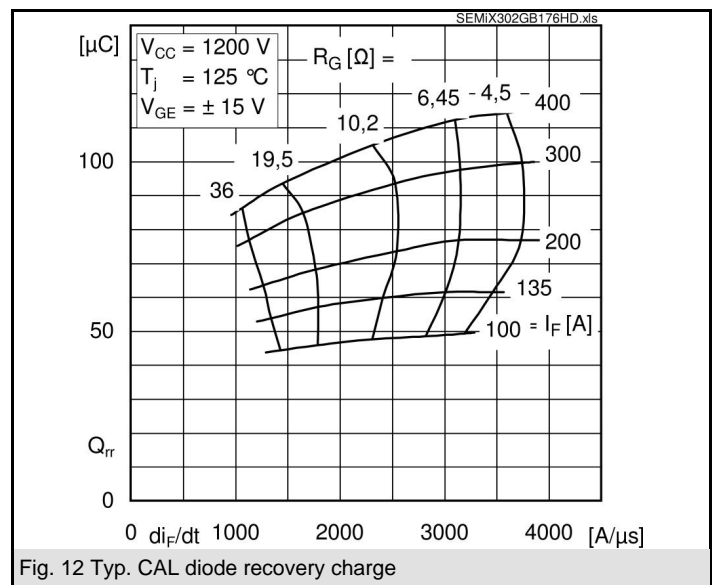
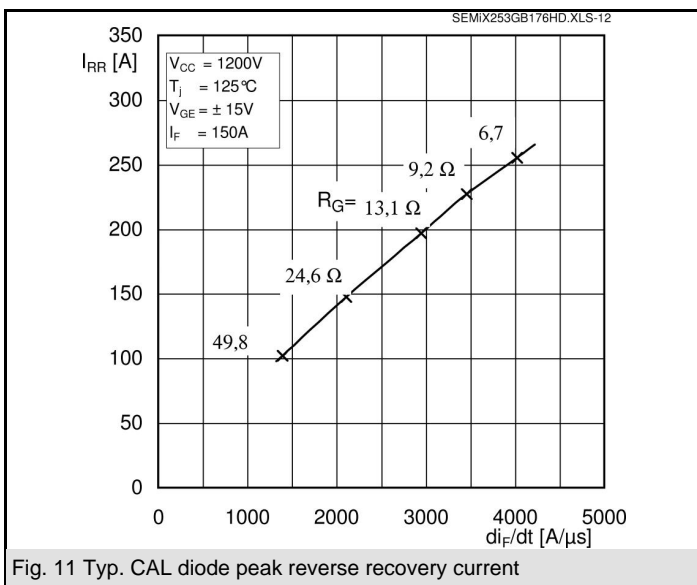
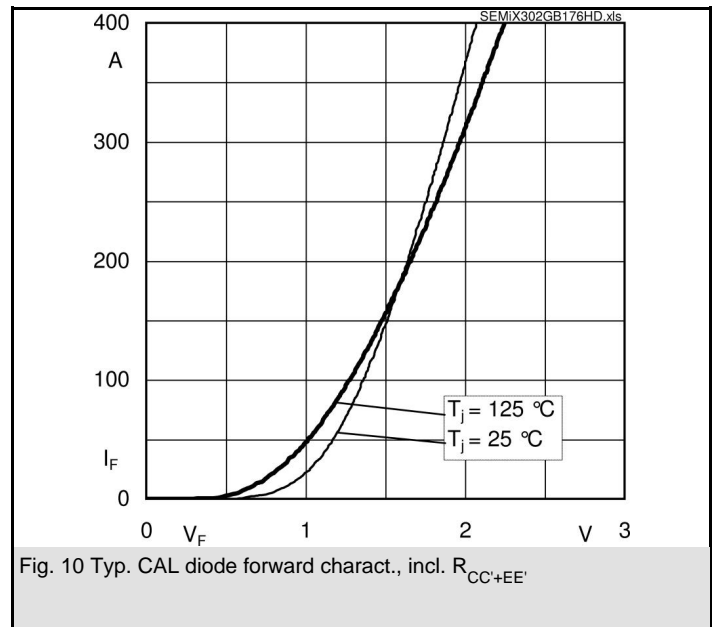
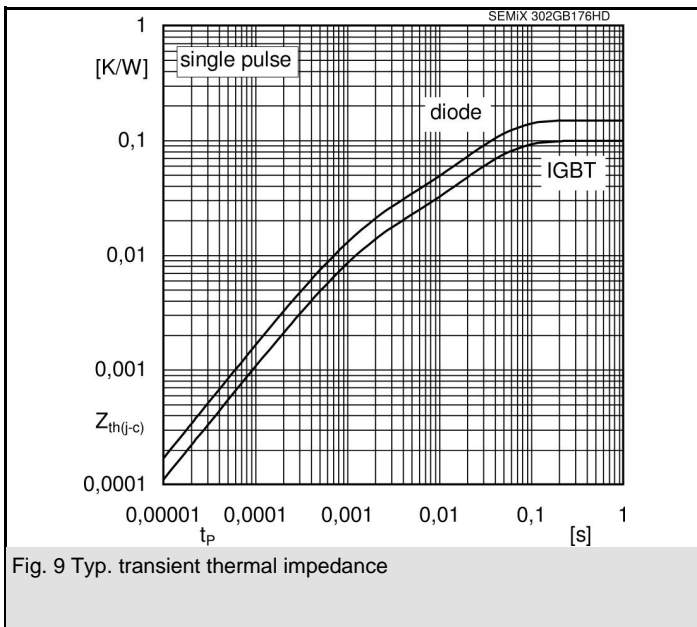
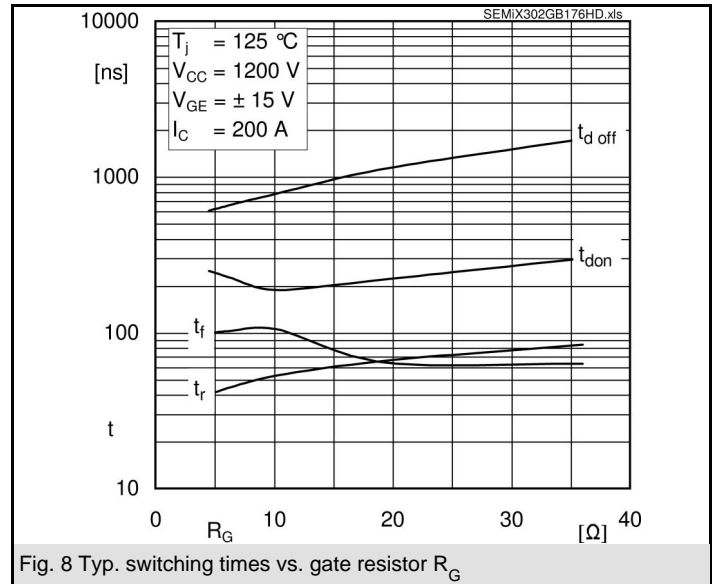
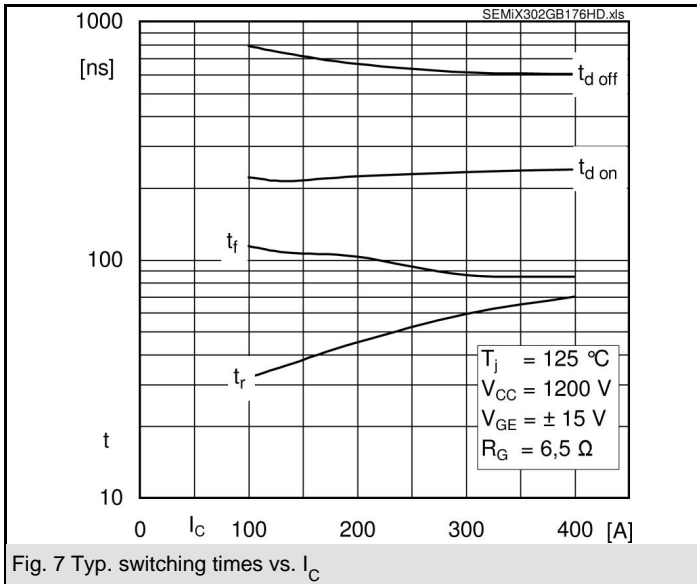
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Characteristics			min.	typ.	max.	Units
Symbol	Conditions					
Inverse Diode						
$V_F = V_{EC}$	$I_{Fnom} = 200 A$; $V_{GE} = 0 V$	$T_j = 25 ^\circ C_{chiplev.}$ $T_j = 125 ^\circ C_{chiplev.}$		1,5 1,45	1,7 1,65	V V
V_{F0}		$T_j = 25 ^\circ C$ $T_j = 125 ^\circ C$		1,1 0,9	1,2 1,1	V V
r_F		$T_j = 25 ^\circ C$ $T_j = 125 ^\circ C$		2 2,7		mΩ mΩ
I_{RRM} Q_{rr} E_{rr}	$I_{Fnom} = 200 A$ $di/dt = 3100 A/\mu s$ $V_{GE} = -15 V$; $V_{CC} = 1200 V$	$T_j = 125 ^\circ C$		235 77 43		A μC mJ
$R_{th(j-c)D}$	per diode				0,15	K/W
Module						
L_{CE}				18		nH
$R_{CC'+EE'}$	res., terminal-chip	$T_{case} = 25 ^\circ C$ $T_{case} = 125 ^\circ C$		0,7 1		mΩ mΩ
$R_{th(c-s)}$	per module			0,045		K/W
M_s	to heat sink M5			3	5	Nm
M_t	to terminals M6			2,5	5	Nm
w					250	g
Temperature sensor						
R_{100}	$T_c = 25 ^\circ C$ ($R_{25} = 5 k\Omega$)			0,493 ±5%		kΩ
$B_{100/125}$	$R(T) = R_{100} \exp[B_{100/125} (1/T - 1/T_{100})]$; $T[K]$; B			3550 ±2%		K

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

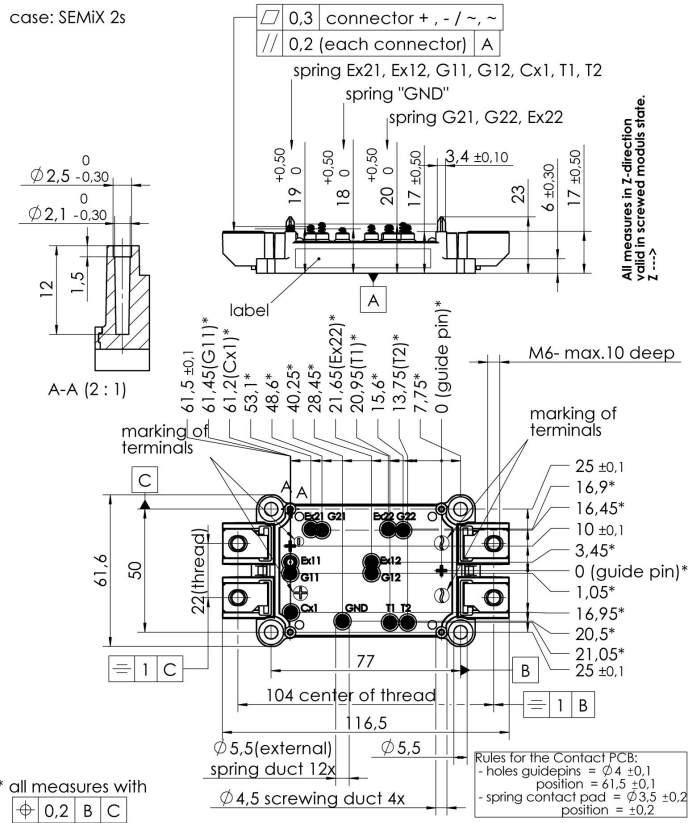
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case: SEMiX 2s



Case SEMiX 2s

